

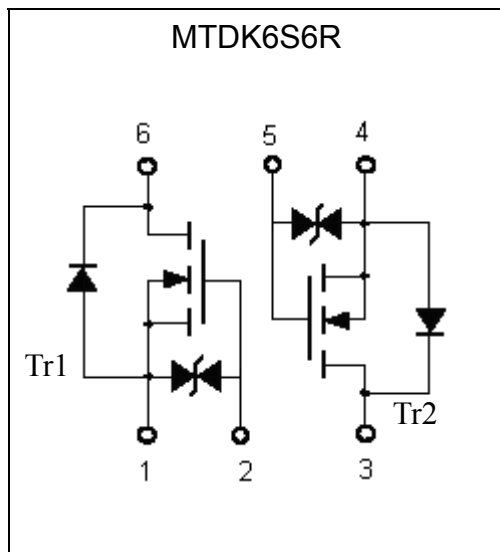
N-CHANNEL MOSFET (dual transistors)

MTDK6S6R

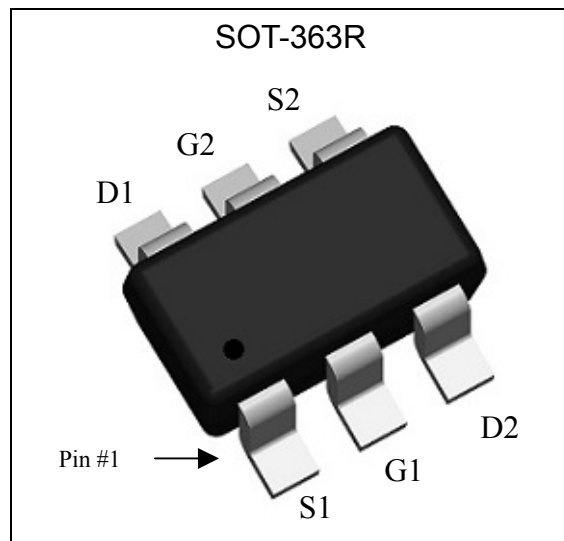
Features

- ESD protected gate, $\geq 2\text{kV}$ (HBM)
- High speed switching
- Easily designed drive circuits
- Easy to use in parallel
- Pb-free lead plating and halogen-free package

Equivalent Circuit

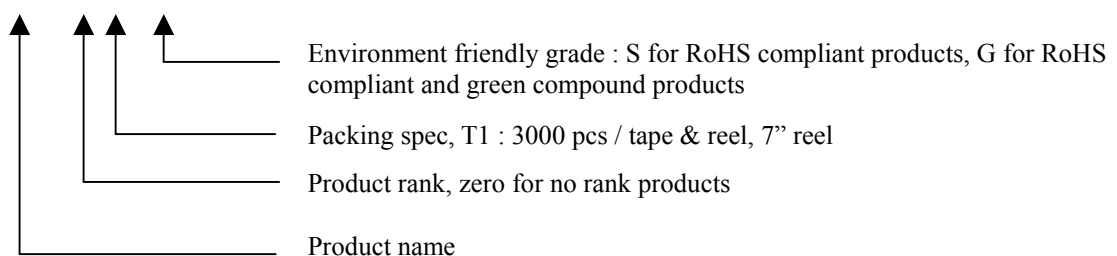


Outline



Ordering Information

| Device | Package | Shipping |
|-----------------|--|------------------------|
| MTDK6S6R-0-T1-G | SOT-363 (Pb-free lead plating and halogen-free package) | 3000 pcs / Tape & Reel |





The following characteristics apply to both Tr1 and Tr2

Absolute Maximum Ratings (Ta=25°C)

| Parameter | Symbol | Limits | Unit |
|---|------------------|----------|------|
| Drain-Source Voltage | V _{DSS} | 60 | V |
| Gate-Source Voltage | V _{GSS} | ±20 | |
| Continuous Drain Current @V _{GS} =10V, T _A =25°C (Note 3) | I _D | 320 | mA |
| Continuous Drain Current @V _{GS} =10V, T _A =70°C (Note 3) | | 256 | |
| Pulsed Drain Current (Notes 1, 2) | I _{DM} | 1300 | |
| Power Dissipation (Note 3) | P _D | 300 | mW |
| ESD susceptibility (Note 4) | V _{ESD} | 2000 | V |
| Operating Junction Temperature Range | T _j | -55~+150 | °C |
| Storage Temperature Range | T _{stg} | -55~+150 | |

Thermal Performance

| Parameter | Symbol | Limit | Unit |
|---|------------------|-------|------|
| Thermal Resistance, Junction-to-Ambient, max (Note 3) | R _{θJA} | 417 | °C/W |
| Thermal Resistance, Junction-to-Case | R _{θJC} | 150 | |

- Note : 1. Pulse width limited by maximum junction temperature.
 2. Pulse width ≤ 300μs, duty cycle ≤ 2%.
 3. Surface mounted on copper pad of FR-4 board with minimum footprint, 2 oz. copper.
 4. Human body model, 1.5kΩ in series with 100pF

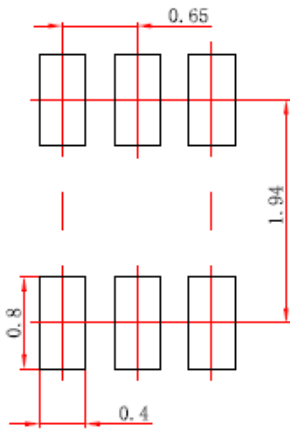
Electrical Characteristics (Ta=25°C)

| Symbol | Min. | Typ. | Max. | Unit | Test Conditions |
|-------------------------------------|------|------|------|--|--|
| BV _{DSS} * | 60 | - | - | V | V _{GS} =0V, I _D =10μA |
| ΔBV _{DSS} /ΔT _j | - | 0.06 | - | V/°C | Reference to 25°C, I _D =250μA |
| V _{GS(th)} | 1 | - | 2.5 | V | V _{DS} =V _{GS} , I _D =250μA |
| I _{GSS} | - | - | ±10 | μA | V _{GS} =±16V, V _{DS} =0V |
| I _{DSS} | - | - | 1 | | V _{DS} =60V, V _{GS} =0V |
| | - | - | 10 | V _{DS} =48V, V _{GS} =0V (T _j =70°C) | |
| R _{DS(ON)} * | - | 1.1 | 2.5 | Ω | I _D =500mA, V _{GS} =10V |
| | - | 1.3 | 3 | | I _D =200mA, V _{GS} =4.5V |
| G _{FS} | 100 | 250 | - | mS | V _{DS} =10V, I _D =100mA |
| C _{iss} | - | 26 | - | pF | V _{DS} =30V, V _{GS} =0V, f=1MHz |
| C _{oss} | - | 9.7 | - | | |
| C _{rss} | - | 2.9 | - | | |
| t _{d(ON)} | - | 3.8 | - | ns | V _{DS} =30V, I _D =0.5A, V _{GS} =10V, R _G =1Ω |
| t _r | - | 15.4 | - | | |
| t _{d(OFF)} | - | 8.6 | - | | |
| t _f | - | 10.8 | - | | |
| Q _g | - | 1.7 | - | nC | V _{DS} =48V, I _D =1A, V _{GS} =10V |
| Q _{gs} | - | 0.6 | - | | |
| Q _{gd} | - | 0.6 | - | | |

| Source-Drain Diode | | | | | |
|--------------------|---|-----|------|----|---|
| I _S | - | - | 0.32 | A | |
| I _{SM} | - | - | 1.3 | | |
| *V _{SD} | - | 0.8 | 1.2 | V | V _{GS} =0V, I _S =0.1A |
| *trr | - | 9.7 | - | ns | I _F =0.5A, dI _F /dt=100A/μs |
| *Q _{rr} | - | 3 | - | nC | |

*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

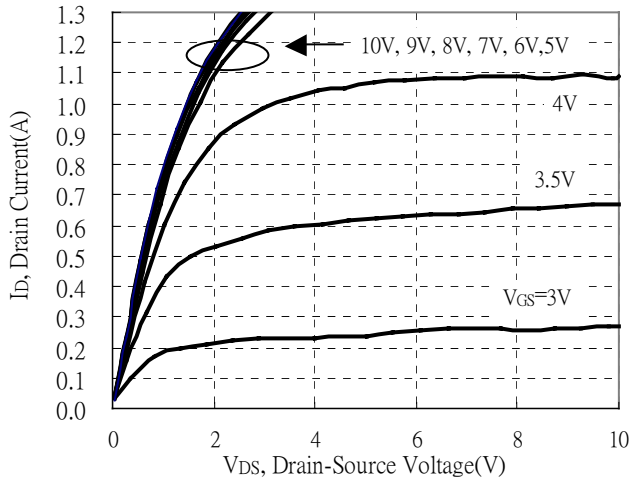
Recommended Soldering Footprint



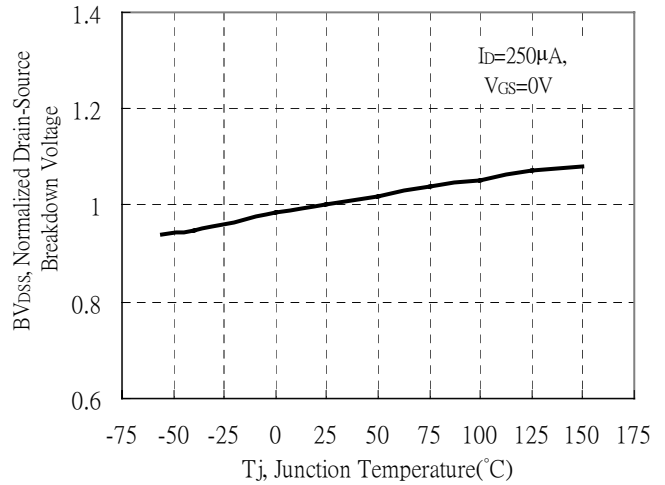
unit : mm

Typical Characteristics

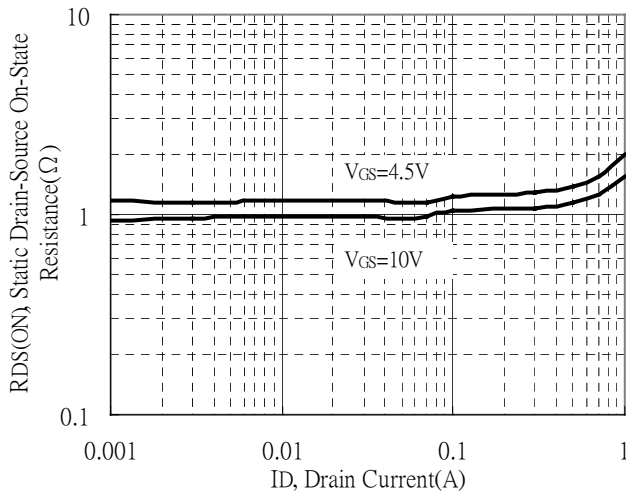
Typical Output Characteristics



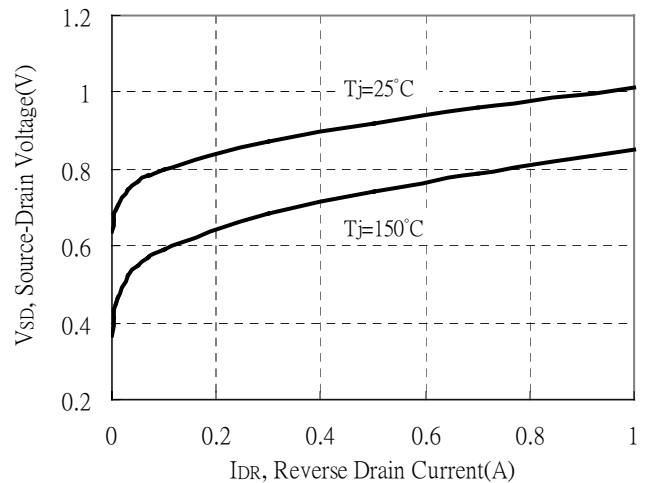
Brekdown Voltage vs Ambient Temperature



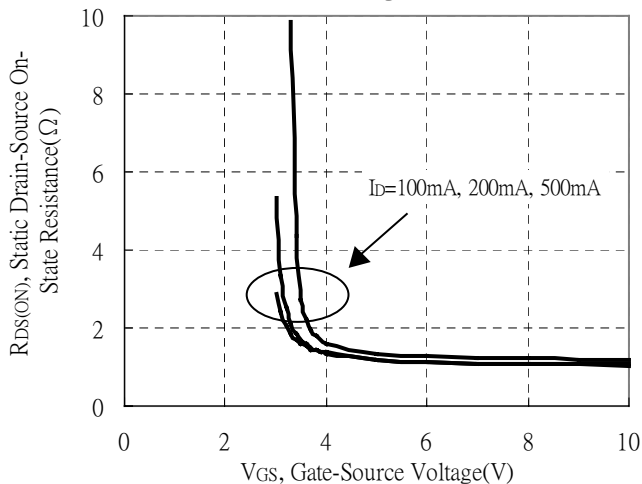
Static Drain-Source On-State resistance vs Drain Current



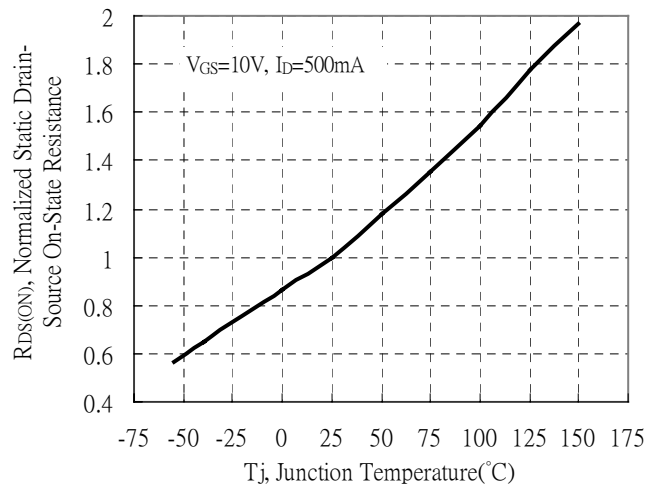
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

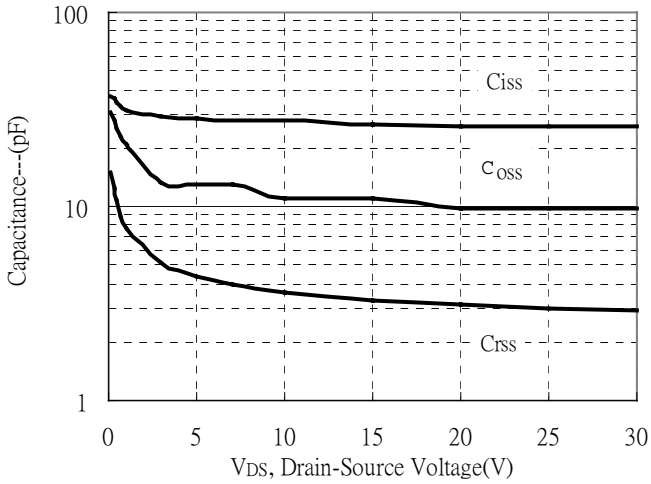


Drain-Source On-State Resistance vs Junction Temperature

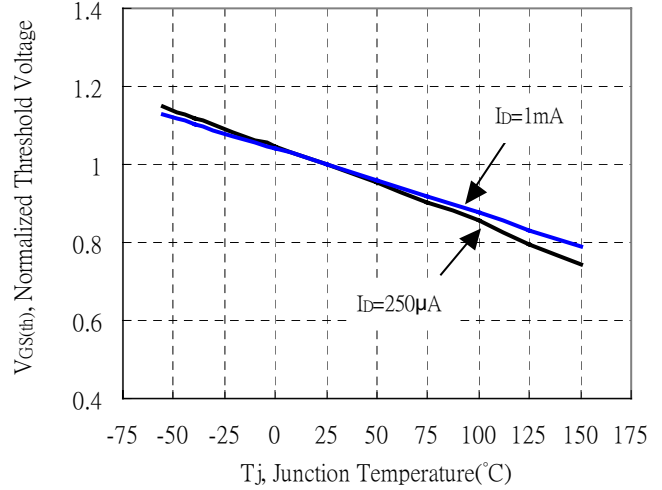


Typical Characteristics(Cont.)

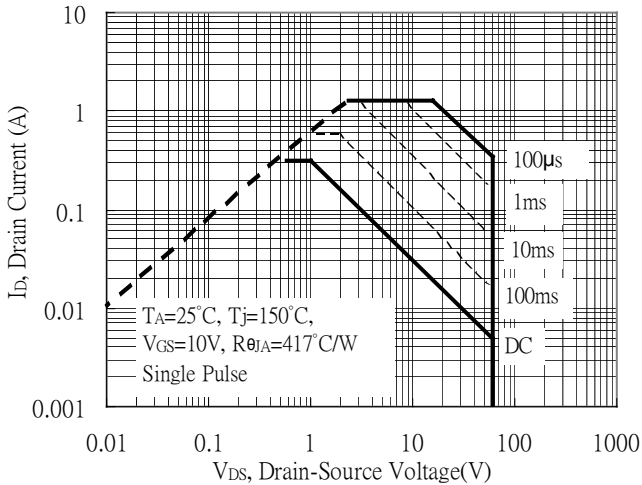
Capacitance vs Drain-to-Source Voltage



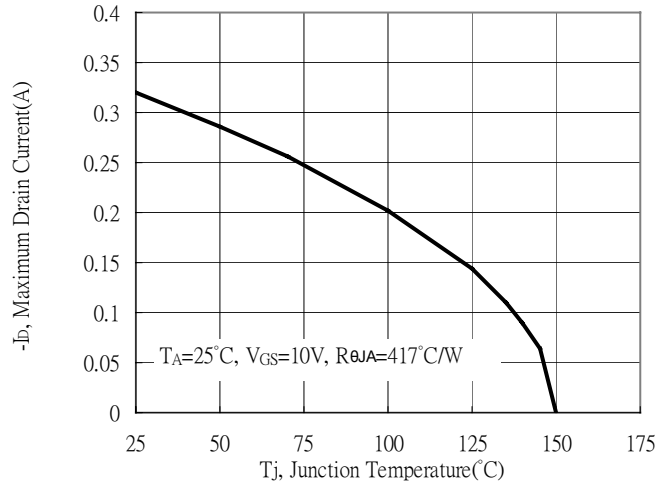
Threshold Voltage vs Junction Temperature



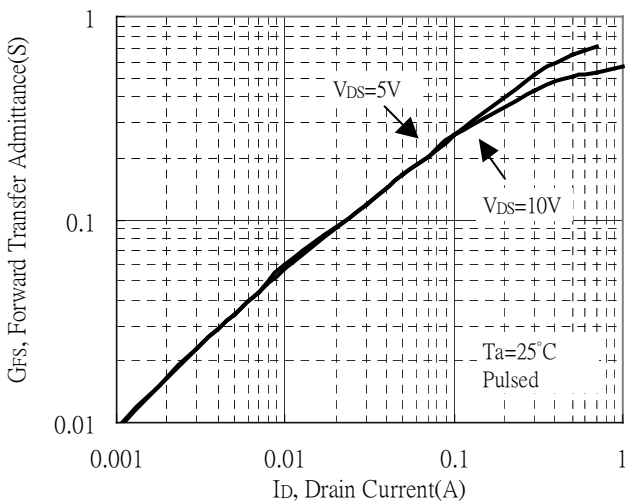
Maximum Safe Operating Area



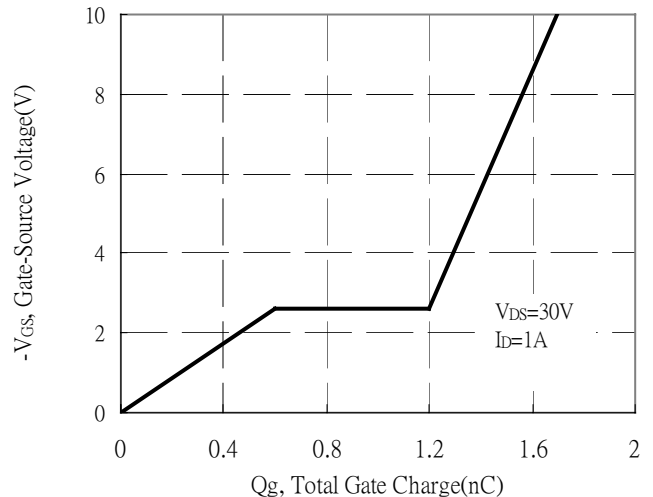
Maximum Drain Current vs Junction Temperature



Forward Transfer Admittance vs Drain Current

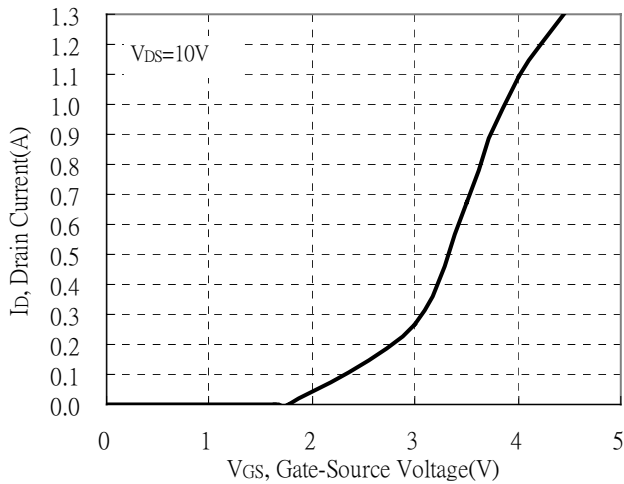


Gate Charge Characteristics

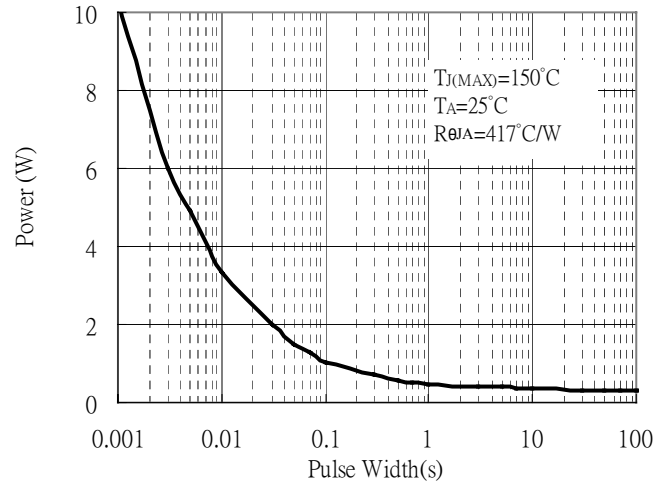


Typical Characteristics(Cont.)

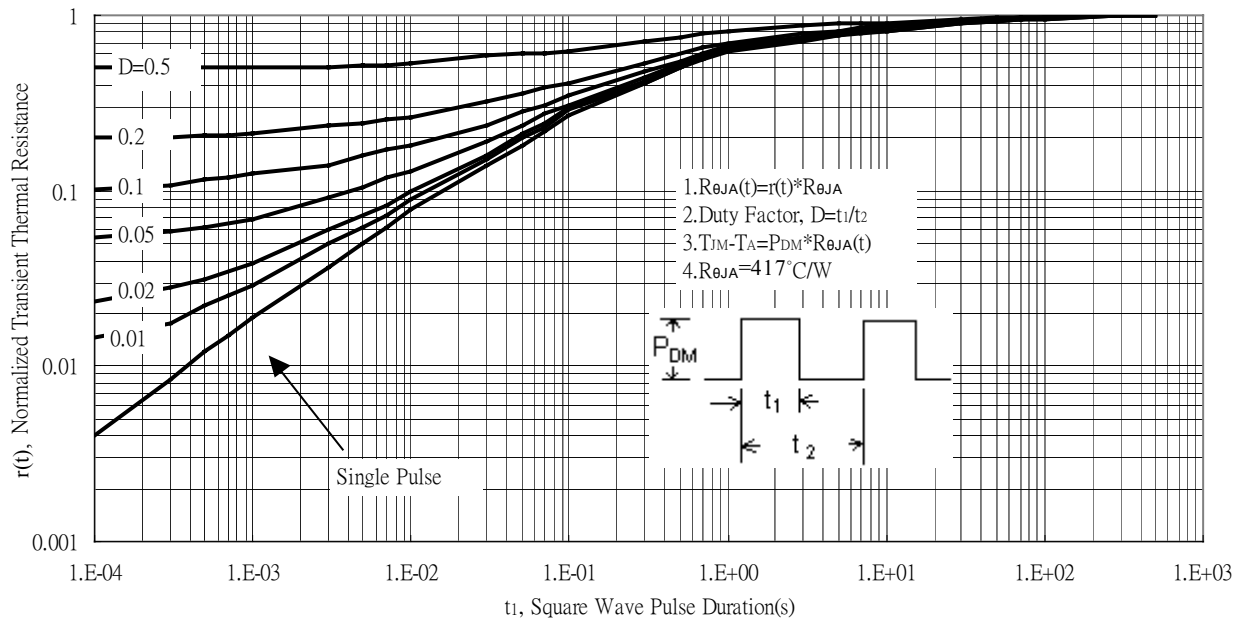
Typical Transfer Characteristics



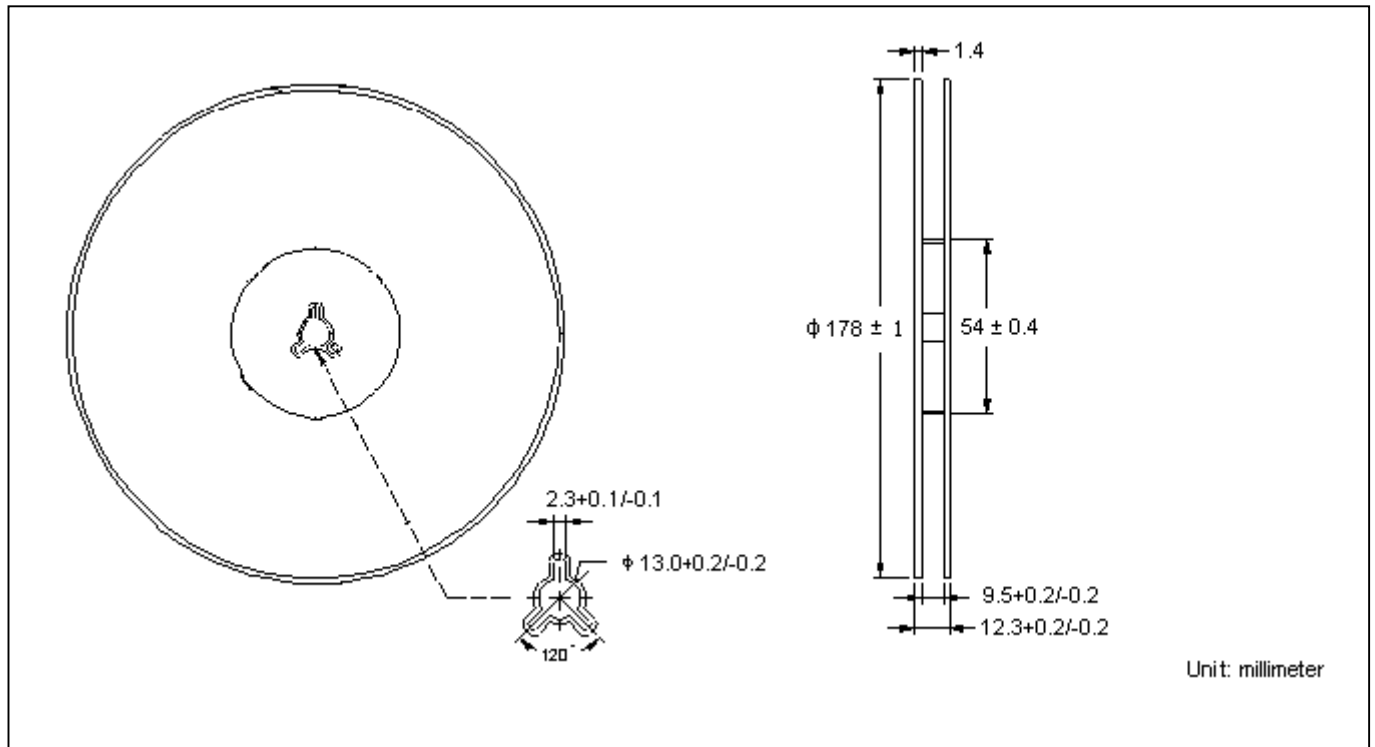
Single Pulse Power Rating, Junction to Ambient
 (Note on page 2)



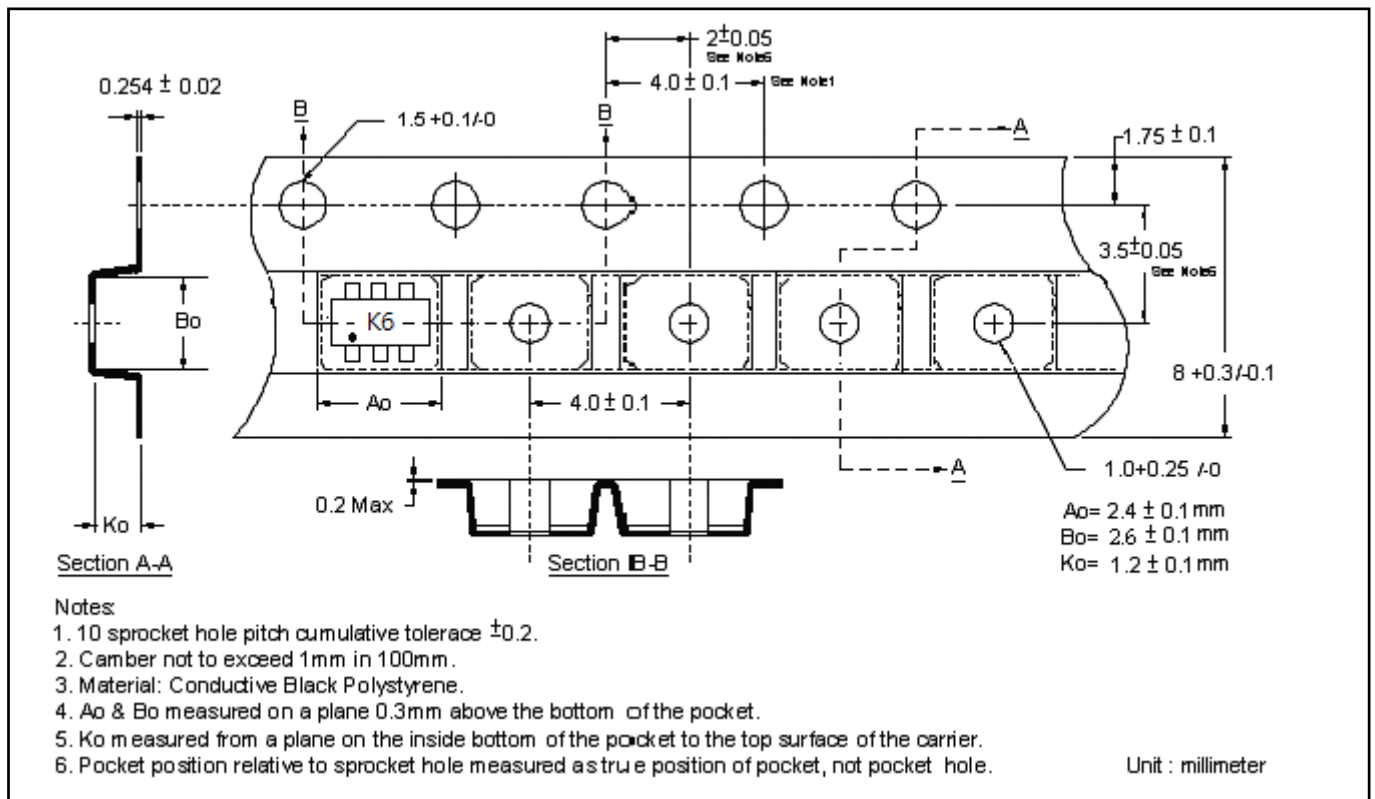
Transient Thermal Response Curves



Reel Dimension



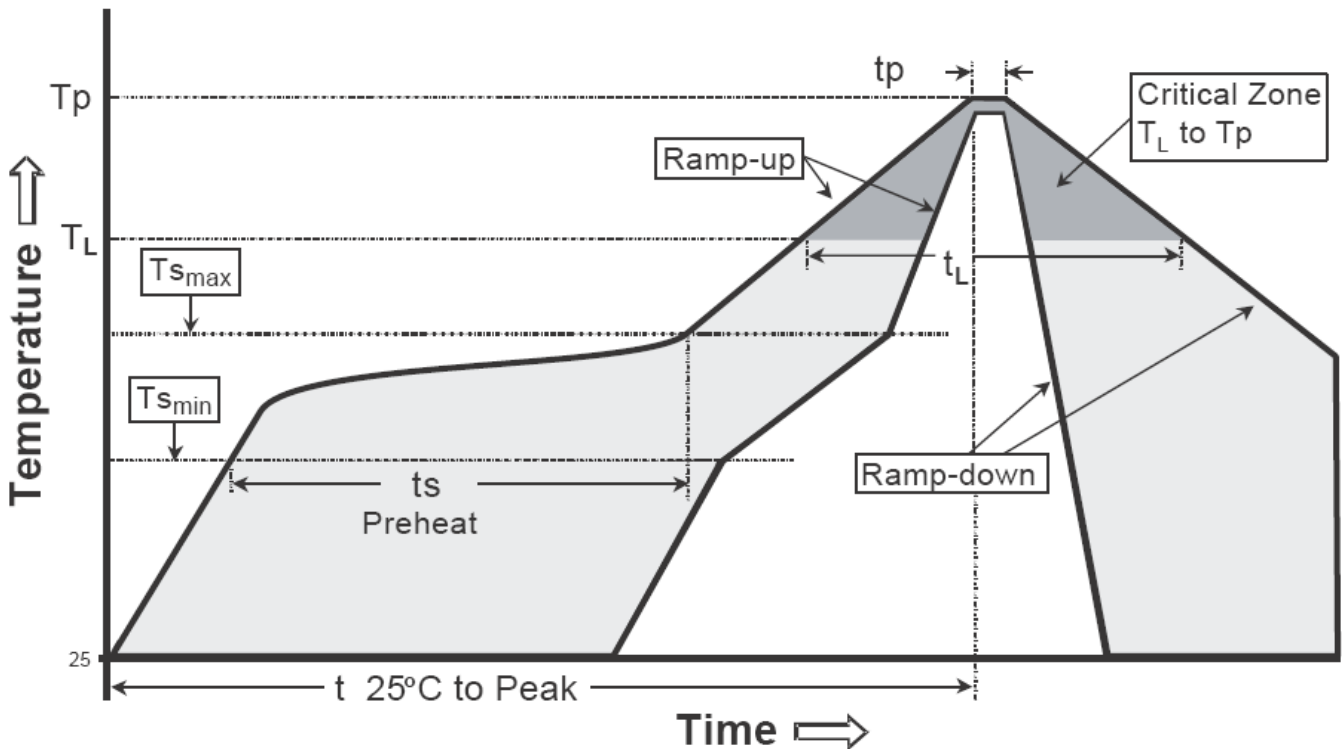
Carrier Tape Dimension



Recommended wave soldering condition

| | | |
|-----------------|------------------|-----------------|
| Product | Peak Temperature | Soldering Time |
| Pb-free devices | 260 +0/-5 °C | 5 +1/-1 seconds |

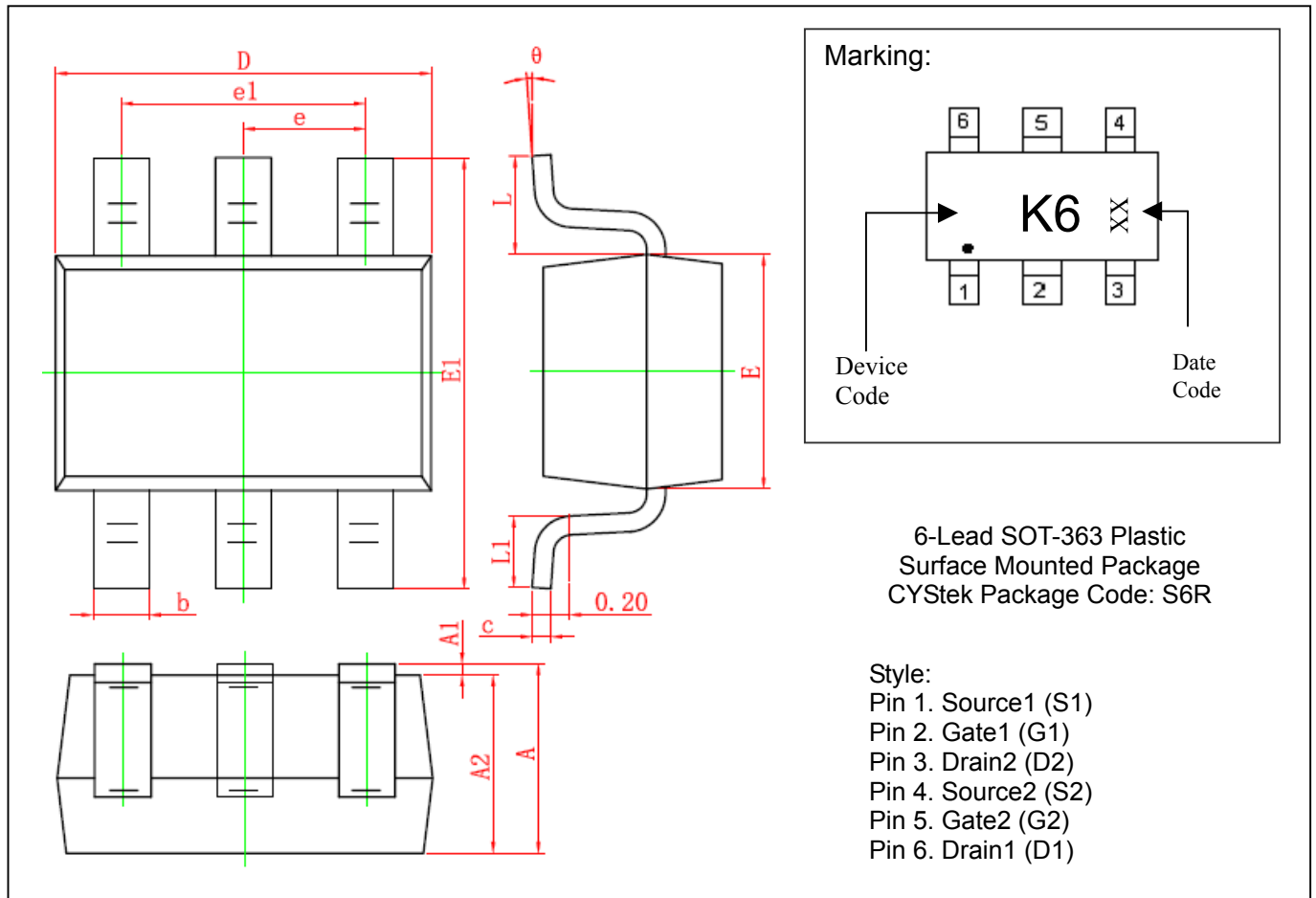
Recommended temperature profile for IR reflow



| Profile feature | Sn-Pb eutectic Assembly | Pb-free Assembly |
|---|-------------------------|------------------|
| Average ramp-up rate (T _{smax} to T _p) | 3°C/second max. | 3°C/second max. |
| Preheat | | |
| -Temperature Min(T _{s min}) | 100°C | 150°C |
| -Temperature Max(T _{s max}) | 150°C | 200°C |
| -Time(t _{s min} to t _{s max}) | 60-120 seconds | 60-180 seconds |
| Time maintained above: | | |
| -Temperature (T _L) | 183°C | 217°C |
| - Time (t _L) | 60-150 seconds | 60-150 seconds |
| Peak Temperature(T _P) | 240 +0/-5 °C | 260 +0/-5 °C |
| Time within 5°C of actual peak temperature(tp) | 10-30 seconds | 20-40 seconds |
| Ramp down rate | 6°C/second max. | 6°C/second max. |
| Time 25 °C to peak temperature | 6 minutes max. | 8 minutes max. |

Note : All temperatures refer to topside of the package, measured on the package body surface.

SOT-363 Dimension



| DIM | Millimeters | | Inches | | DIM | Millimeters | | Inches | |
|-----|-------------|-------|--------|-------|-----|-------------|-------|-----------|-------|
| | Min. | Max. | Min. | Max. | | Min. | Max. | Min. | Max. |
| A | 0.900 | 1.100 | 0.035 | 0.043 | E1 | 2.150 | 2.450 | 0.085 | 0.096 |
| A1 | 0.000 | 0.100 | 0.000 | 0.004 | e | 0.650 TYP | | 0.026 TYP | |
| A2 | 0.900 | 1.000 | 0.035 | 0.039 | e1 | 1.200 | 1.400 | 0.047 | 0.055 |
| b | 0.150 | 0.350 | 0.006 | 0.014 | L | 0.525 REF | | 0.021 REF | |
| c | 0.080 | 0.150 | 0.003 | 0.006 | L1 | 0.260 | 0.460 | 0.010 | 0.018 |
| D | 2.000 | 2.200 | 0.079 | 0.087 | θ | 0° | 8° | 0° | 8° |
| E | 1.150 | 1.350 | 0.045 | 0.053 | | | | | |

Notes : 1.Controlling dimension : millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material :

- Lead : Pure tin plated.
- Mold Compound : Epoxy resin family, flammability solid burning class:UL94V-0.

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